

Issue Classification 	Application No.	Applicant(s)
	09/604,301	TSUTSUI ET AL.
	Examiner	Art Unit
	Hau H Nguyen	2676

ORIGINAL			CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
345	536	345	560	547	51	100	204			
INTERNATIONAL CLASSIFICATION										
606	F	13100								
		/								
		/								
		/								
		/								
Hau H Nguyen 12/16/2004 (Assistant Examiner) (Date)			Matthew C. Bella SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner) (Date)						Total Claims Allowed: 19	
O. G. Instruments Examiner 12/19/04 (Date)									O.G. Print Claim(s) 1	O.G. Print Fig. 5

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
6	6	36	66	96	126	156	186
7	7	37	67	97	127	157	187
8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
10	10	40	70	100	130	160	190
11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
13	13	43	73	103	133	163	193
14	14	44	74	104	134	164	194
15	15	45	75	105	135	165	195
16	16	46	76	106	136	166	196
17	17	47	77	107	137	167	197
18	18	48	78	108	138	168	198
19	19	49	79	109	139	169	199
20		50	80	110	140	170	200
21		51	81	111	141	171	201
22		52	82	112	142	172	202
23		53	83	113	143	173	203
24		54	84	114	144	174	204
25		55	85	115	145	175	205
26		56	86	116	146	176	206
27		57	87	117	147	177	207
28		58	88	118	148	178	208
29		59	89	119	149	179	209
30		60	90	120	150	180	210